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Bib Data Sheet

CONFIRMATION NO. 9100

SERIAL NUMBER 10/662,107	FILING DATE 09/12/2003 RULE	CLASS 250	GROUP ART UNIT 2878	ATTORNEY DOCKET NO. 42P16017
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APPLICANTS

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**** CONTINUING DATA ******* NONE
OG

**** FOREIGN APPLICATIONS ******* NONE
OG

IF REQUIRED, FOREIGN FILING LICENSE GRANTED
**** 12/17/2003**

Foreign Priority claimed <input type="checkbox"/> yes <input checked="" type="checkbox"/> no 35 USC 119 (a-d) conditions <input type="checkbox"/> yes <input checked="" type="checkbox"/> no <input type="checkbox"/> Met after met Allowance <u>OG</u> Verified and Acknowledged _____ Examiner's Signature Initials	STATE OR COUNTRY CA	SHEETS DRAWING 5	TOTAL CLAIMS 27	INDEPENDENT CLAIMS 3
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TITLE
 Critical dimension measurement by diffraction

FILING FEE RECEIVED 876	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____
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